

PTO/SB/08a/b (07-05)

Approved for use through 07/31/2006, OMB 0651-0031

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Su	bstitute for form 1449A/E	зурто		Complete if Known		
				Application Number	10/036,135-Conf. #3390	
	NFORMATIO	ON DISC	LOSURE	Filing Date	November 7, 2001	
S	STATEMENT	T BY AP	PLICANT	First Named Inventor	Yeshik Shin	
				Art Unit	2665	
	(Use as many	sheets as nec	essary)	Examiner Name	S. H. D. Nguyen	
Sheet	1	of	3	Attorney Docket Number	594728813US	

			U.S. PA	TENT DOCUMENTS	
Examiner Initials*	Cite No.'	Document Number Number-Kind Code ² (if known)	Publication Date MM-OD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
SN	W.	US-2002-0154633-A1	10-24-2002	Shin et al.	
SN	AB*	US-2002-0157054-A1		Shin et al.	
SN	AC*	US-2002-0159450-A1	10-31-2002	Shin et al.	
SN	AD*	US-2002-0159552-A1	10-31-2002	Shin et al.	
SN	AE*	US-2002-0167945-A1	11-14-2002	Shin et al.	***************************************
sn	AF*	US-2002-0172200-A1	11-21-2002	Shin et al.	
	AG*	US-2002-0191475-A1		Lee et al.	<u> </u>
	AH*	US-2002-0191603-A1	12-19-2002	Shin et al.	
sn sn	Al*	US-20020035633	03/2002	Bose et al.	
sn	AJ°	US-20020041650	04/2002	Richmond	
sn	AK*	US-20020049825	04/2002	Jewett et al.	
sn	AL.	US-20020122420	09/2002	Yuan et al.	
an sn	AM*	US-20020171741	11/2002	Tonkin et al.	
sn sn	AN.	US-2003-0208655-A1	11-06-2003	Lee et al.	
sn	40°	US-2003-0210162-A1	11-13-2003	Shin et al.	
sn	AP*	US-2003-0227947-A1		Shin et al.	
sn	AQ*	US-20030140300	07/2003	Chen et al.	
sn sn	AR*	US-20030189922	10/2003	Howe	
	AS*	US-2004-0004975-A1	01-08-2004	Shin et al.	
sn sii	AT*	US-20050018697	01/2005	Enns et al.	
-	AU*	US-4,425,666	01/1984	Groth, Jr.	
sn sn	AV*	US-4,658,396	04-14-1987	Barden	
	AW.	US-4,672,639	06-09-1987	Tanabe et al.	
sn sn	YX.	US-4,797,850		Amitai	
sn	AY	US-4,945,548	07/1990	lannarone et al.	
sn Bii	AZ*	US-4,972,314		Getzinger et al.	
	AA1°	US-5,307,314	04-26-1994		
sn sn		US-5,400,323		Frenzel, III et al.	
		US-5,430,485		Lankford et al.	- +
sn		US-5,539,696		Patel	
		US-5,557,608	09/1996	Calvignac et al.	
		US-5,561,618	10/1996	Dehesh	
sn		US-5,574,849		Sonnier et al.	
sn		US-5,583,872		Albrecht et al.	
sn	Al1	US-5,587,709		Jeong	
sn	AJ1°	US-5,588,025		Strolle et al.	
sn sn		US-5,592,487	01/1997	Knecht et al.	
sn	AL1	US-5,663,724	09/1997	Westby	
		US-5,699,367	12-16-1997	Haartsen	
		US-5,703,875	12-10-1997	Burnett	
sn		US-5,751,947	05/1998	Arakawa	
sn		US-5,825,824	10-20-1998		-
				Lee et al.	
		US-5,838,960	11/1998	Harriman, Jr.	
sn		US-5,872,777	02/1999	Brailean et al.	
sn	AS1°	US-5,963,703	10/1999	Higurashi et al.	

Examiner		Date	
Signature	/Steven Nauven/	Considered	06/11/2006

Sub	stitute for form 1449A/I	в/РТО		Complete if Known		
				Application Number	10/036,135-Conf. #3390	
11	IFORMATIC	ON DISC	CLOSURE	Filing Date	November 7, 2001	
S	TATEMENT	T BY AP	PLICANT	First Named Inventor	Yeshik Shin	
				Art Unit	2665	
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Sheet	2	of	3	Attorney Docket Number	594728813US	

Lan		AT1*	US-5,974,464	10-26-1999	Shin et al.	
	sn	AU1°	US-5,983,287	11-09-1999	Kuroiwa et al.	
sn	1	AV1*	US-5,999,571	12-07-1999	Shin et al.	
	sn	AW1	US-6,016,510	01-18-2000	Quattromani et al.	
		•				1
sn			US-6,026,124	02-15-2000	Lee et al.	
	sn	AY1*	US-6,151,334	11-21-2000	Kim et al.	
SI			US-6,154,464	11/2000	Feuerstraeter et al.	
	gr	AA2°	US-6,188,337	02/2001	Soljanin	
sn		AB2*	US-6,188,670	02/2001	Lackman et al.	
	sn	AC2*	US-6,198,413	03/2001	Widmer	
sn			US-6,229,859	05-08-2001	Jeong et al.	
	sn	AE2*	US-6,266,335	07/2001	Bhaskaran	
an			US-6,400,730	06-04-2002	Latif et al.	
		AG2*	US-6,415,353	07-02-2002	Leung	
sn			US-6,430,230	08/2002	Cunningham et al.	
	SD	Al2°	US-6,438,128	08-20-2002	Kashyap	
sn			US-6,470,391	10/2002	Takamoto et al.	
	sn		US-6,560,290-A1	05-06-2003	Ahn et al.	
sn			US-6,560,728	05-06-2003	Merritt	
			US-6,587,525-A1	07-01-2003	Jeong et al.	
<u>sn</u>		AN2*	US-6,594,325	07/2003	Li	
			US-6,594,329	07/2003	Susnow	
вn			US-6,738,821	05/2004 .	Wilson et al.	
	sn		US-6,771,192	08-03-2004	Lee et al.	
sn			US-6,791,952	09/2004	Lin et al.	
	SD	AS2*	US-6,826,199	11-30-2004	Davidsson et al.	

		FOREI	GN PATENT	DOCUMENTS		_
Examiner	Cite	Foreign Patent Document	Publication	Name of Patentee or	Pages, Columns, Lines,	
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ³ (if known)	MM-DD-YYYY	Applicant of Cited Document	Where Relevant Passages or Relevant Figures Appear	76
sn	BA	WO-97/13347-A2	04-10-1997	Silicon Image, Inc.		М
gn	ВВ	WO-99/12306-A1	03-11-1999	Silicon Image, Inc.		
gn	ВС	WO-97/36408-A2	10-02-1997	Silicon Image, Inc.		
sn	BD	WO-02/058318-A1	07-25-2002	Silicon Image, Inc.		\vdash
	BE	EP-0582537A2	09-02-1994	International Business		
sn				Machines Corporation		

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		NON PATENT LITERATURE	DOCUMENTS		
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of magazine, journal, serial, symposium, catalog, etc.), date and/or country who	e, page(s), volume-issue numi	, title of the Item (book, ber(s), publisher, city	T²
Examiner Signature		/Steven Nguyen/	Date Considered	06/11/200	6

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	(Use as man	y sheets a	s necessary)	Examiner Name	S. H. D. Nguyen	
heet	3	of	3	Attorney Docket Number	594728813US	

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sn (CA	Richmond, Serial protocol elastic buffer description, 07/11/00, 60/217520, Pages 1-13	1
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